

Device Modeling Report

COMPONENTS:

DIODE/ GENERAL PURPOSE RECTIFIER/ PROFESSIONAL

PART NUMBER: RURD660S

MANUFACTURER: FAIRCHILD

REMARK: TC=80 degree

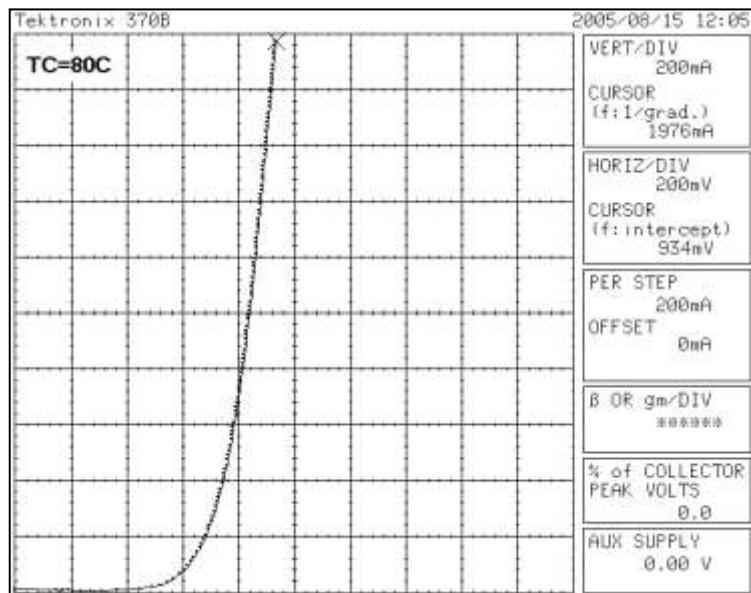


Bee Technologies Inc.

PSpice model parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time
EG	Energy-band Gap

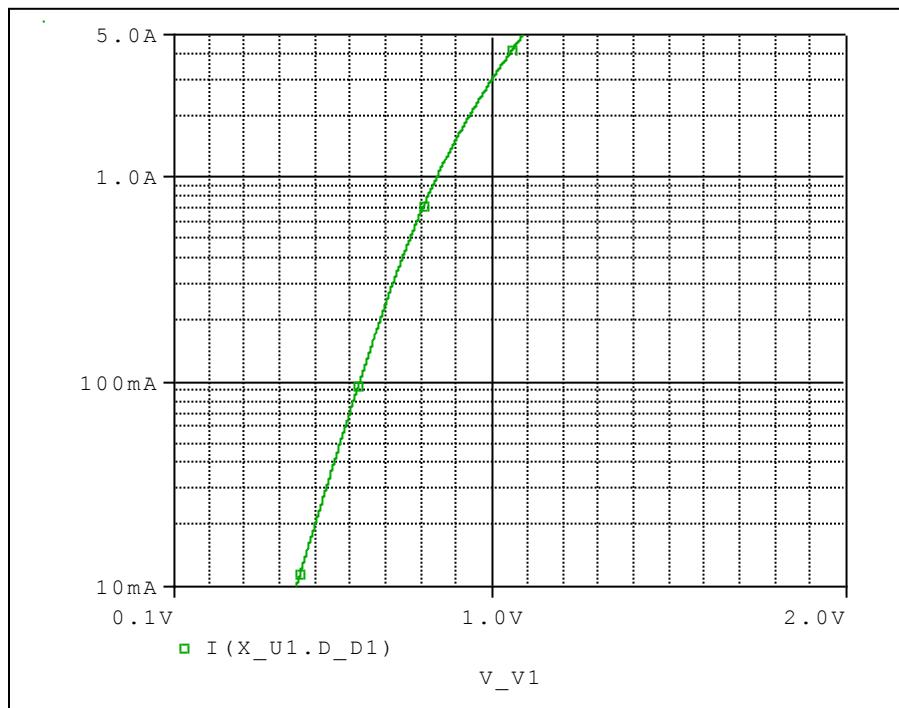
Forward Current Characteristic

Reference

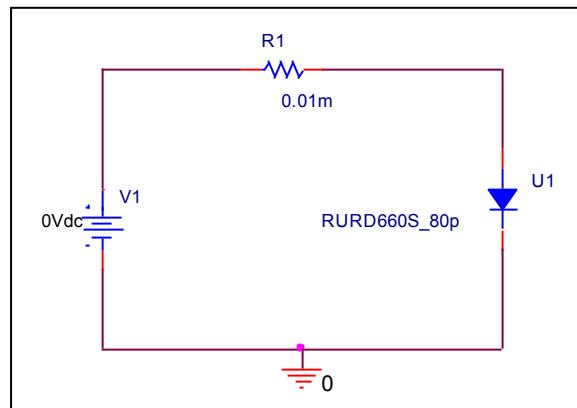


Forward Current Characteristic

Circuit Simulation Result

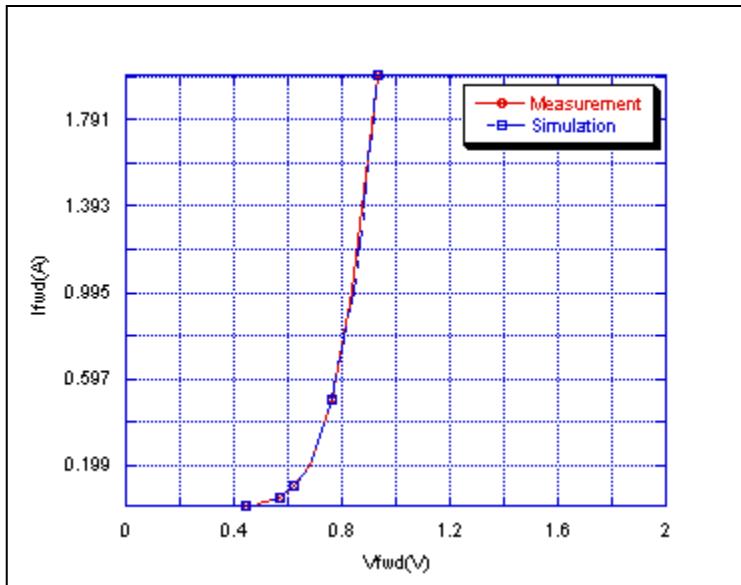


Evaluation Circuit



Comparison Graph

Circuit Simulation Result

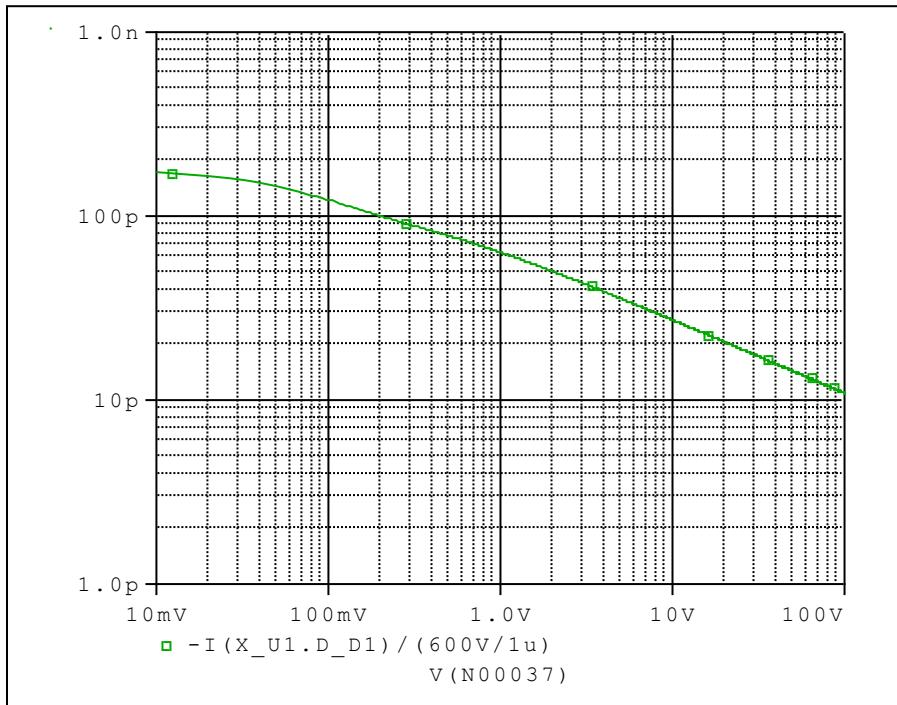


Simulation Result

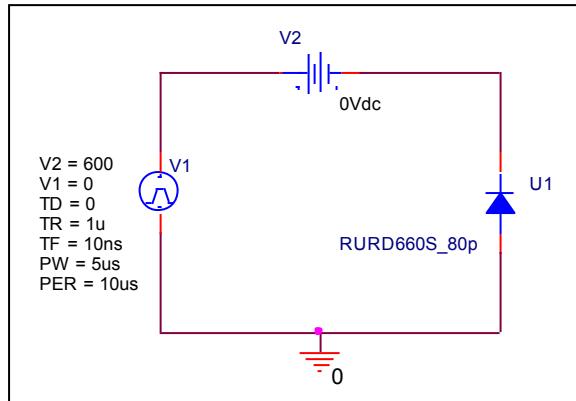
I_{fwd} (A)	V_{fwd} (V) Measurement	V_{fwd} (V) Simulation	%Error
0.01	0.448	0.444	0.893
0.02	0.492	0.497	-1.016
0.05	0.570	0.568	0.351
0.1	0.620	0.623	-0.484
0.2	0.684	0.680	0.585
0.5	0.766	0.765	0.131
1	0.840	0.841	-0.119
2	0.934	0.933	0.107

Capacitance Characteristic

Circuit Simulation Result

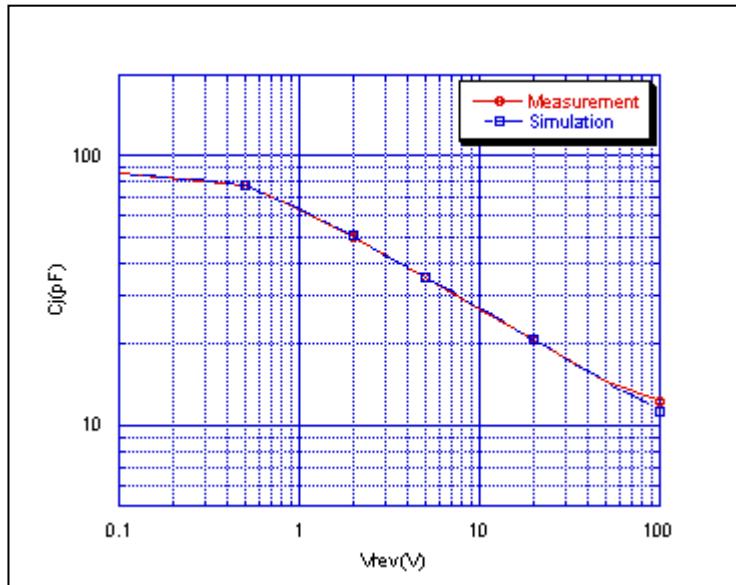


Evaluation Circuit



Comparison Graph

Circuit Simulation Result

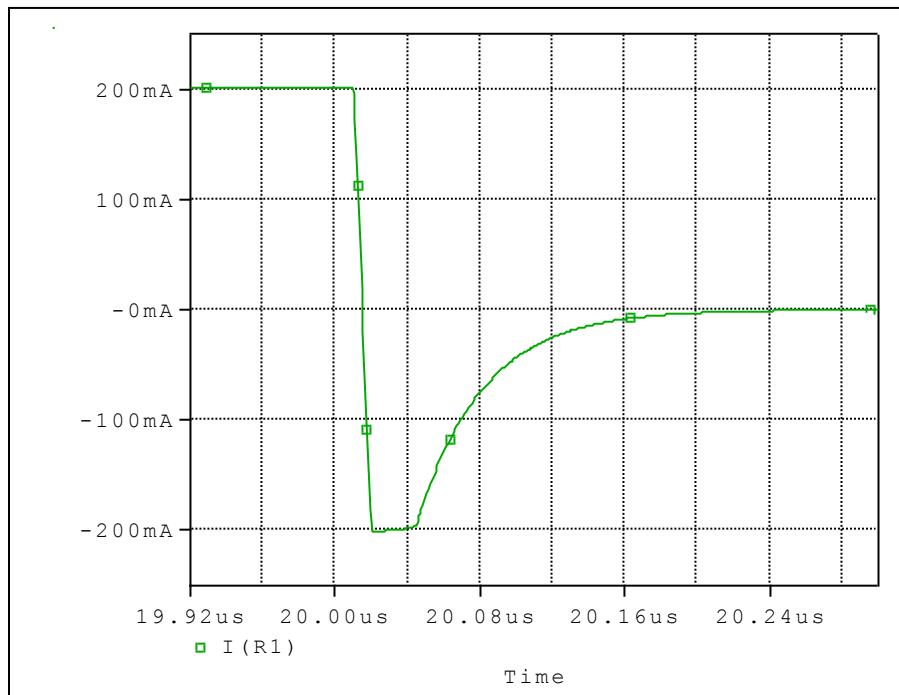


Simulation Result

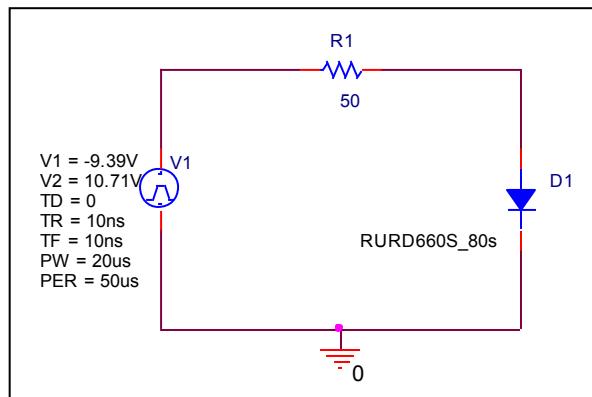
$V_{rev}(V)$	$C_j(pF)$ Measurement	$C_j(pF)$ Simulation	%Error
0	120.800	120.800	0.000
0.5	77.800	78.159	-0.461
1	62.800	63.576	-1.236
2	50.000	50.173	-0.346
5	35.000	35.500	-1.429
10	27.000	27.200	-0.741
20	20.800	20.893	-0.447
50	14.500	14.454	0.317

Reverse Recovery Characteristic

Circuit Simulation Result



Evaluation Circuit

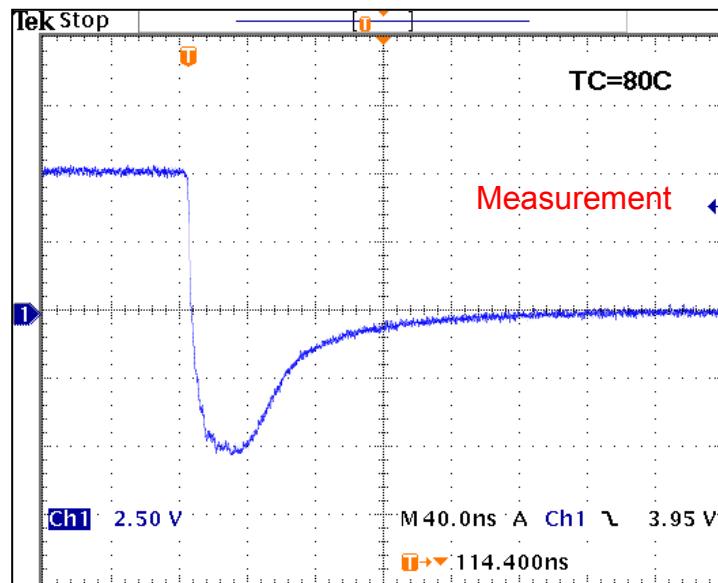


Compare Measurement vs. Simulation

	Measurement		Simulation		%Error
trj	28.8	ns	28.90	ns	0.347
trb	84.0	ns	84.07	ns	0.083

Reverse Recovery Characteristic

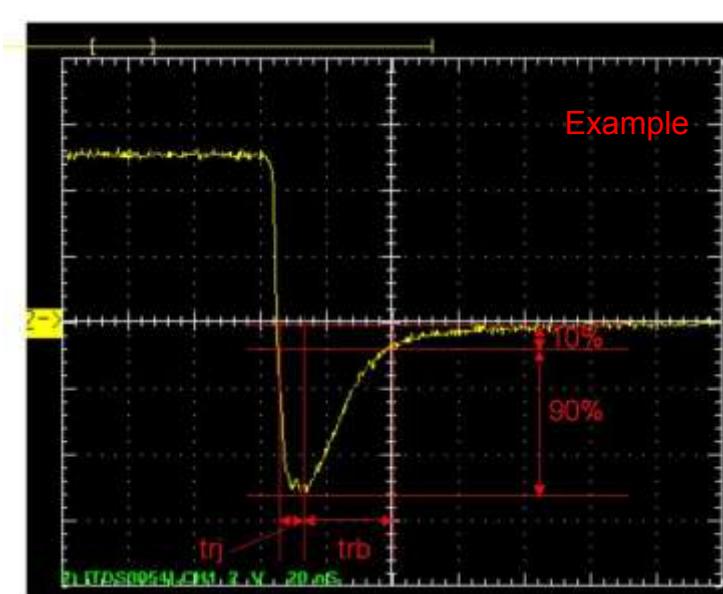
Reference



Trj =28.8 (ns)

Trb= 84.0(ns)

Conditions: Ifwd=Irev=0.2(A), RI=50



Relation between trj and trb